

100301 Low Power Triple 5-Input OR/NOR Gate

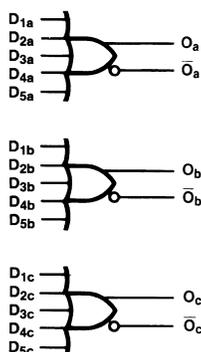
Check for Samples: [100301](#)

FEATURES

- 23% power reduction of the 100101
- 2000V ESD protection
- Pin/function compatible with 100101
- Voltage compensated operating range = -4.2V to -5.7V
- Standard Microcircuit Drawing
 - (SMD) 5962-9152801

DESCRIPTION

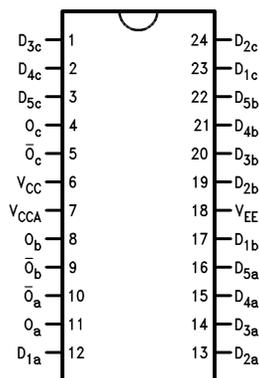
The 100301 is a monolithic triple 5-input OR/NOR gate. All inputs have 50 k Ω pull-down resistors and all outputs are buffered.



Pin Names	Description
D_{na}, D_{nb}, D_{nc}	Data Inputs
O_a, O_b, O_c	Data Outputs
$\bar{O}_a, \bar{O}_b, \bar{O}_c$	Complementary Data Outputs

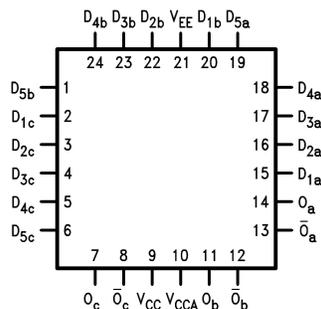
Connection Diagram

Figure 1. 24-Pin DIP



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Figure 2. 24-Pin Quad Cerpak

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings ⁽¹⁾

Above which the useful life may be impaired	
Storage Temperature (T_{STG})	-65°C to +150°C
Maximum Junction Temperature (T_J)	
Ceramic	+175°C
V_{EE} Pin Potential to	
Ground Pin	-7.0V to +0.5V
Input Voltage (DC)	V_{EE} to +0.5V
Output Current (DC Output HIGH)	-50 mA
ESD ⁽²⁾	≥2000V

(1) Absolute Maximum Ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

(2) ESD testing conforms to MIL-STD-883, Method 3015.

Recommended Operating Conditions

Case Temperature (T_C)	
Military	-55°C to +125°C
Supply Voltage (V_{EE})	-5.7V to -4.2V

**Military Version
DC Electrical Characteristics**
 $V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = V_{CCA} = GND$, $T_C = -55^{\circ}C$ to $+125^{\circ}C$

Symbol	Parameter	Min	Max	Units	T_C	Conditions		Notes
V_{OH}	Output HIGH Voltage	-1025	-870	mV	$0^{\circ}C$ to $+125^{\circ}C$			
		-1085	-870	mV	$-55^{\circ}C$	$V_{IN} = V_{IH(Max)}$	Loading with	
⁽¹⁾⁽²⁾⁽³⁾ V_{OL}	Output LOW Voltage	-1830	-1620	mV	$0^{\circ}C$ to $+125^{\circ}C$	or V_{IL} (Min)	50 Ω to $-2.0V$	
		-1830	-1555	mV	$-55^{\circ}C$			
V_{OHC}	Output HIGH Voltage	-1035		mV	$0^{\circ}C$ to $+125^{\circ}C$			
		-1085		mV	$-55^{\circ}C$	$V_{IN} = V_{IH(Min)}$	Loading with	(1) (2) (3)
V_{OLC}	Output LOW Voltage		-1610	mV	$0^{\circ}C$ to $+125^{\circ}C$	or V_{IL} (Max)	50 Ω to $-2.0V$	
			-1555	mV	$-55^{\circ}C$			
V_{IH}	Input HIGH Voltage	-1165	-870	mV	$-55^{\circ}C$ to $+125^{\circ}C$	Guaranteed HIGH Signal		(1) (2) (3) (4)
						for All Inputs		
V_{IL}	Input LOW Voltage	-1830	-1475	mV	$-55^{\circ}C$ to $+125^{\circ}C$	Guaranteed LOW Signal		(1) (2) (3) (4)
						for All Inputs		
I_{IL}	Input LOW Current	0.50		μA	$-55^{\circ}C$ to $+125^{\circ}C$	$V_{EE} = -4.2V$		(1) (2) (3)
						$V_{IN} = V_{IL(Min)}$		
I_{IH}	Input HIGH Current		240	μA	$0^{\circ}C$ to $+125^{\circ}C$	$V_{EE} = -5.7V$		(1) (2) (3)
			340	μA	$-55^{\circ}C$	$V_{IN} = V_{IH} (Max)$		
I_{EE}	Power Supply Current	-32	-12	mA	$-55^{\circ}C$ to $+125^{\circ}C$	Inputs Open		(1) (2) (3)

- (1) F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals $-55^{\circ}C$), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.
- (2) Screen tested 100% on each device at $-55^{\circ}C$, $+25^{\circ}C$, and $+125^{\circ}C$, Subgroups 1, 2, 3, 7, and 8.
- (3) Sample tested (Method 5005, Table I) on each manufactured lot at $-55^{\circ}C$, $+25^{\circ}C$, and $+125^{\circ}C$, Subgroups A1, 2, 3, 7, and 8.
- (4) Guaranteed by applying specified input condition and testing V_{OH}/V_{OL} .

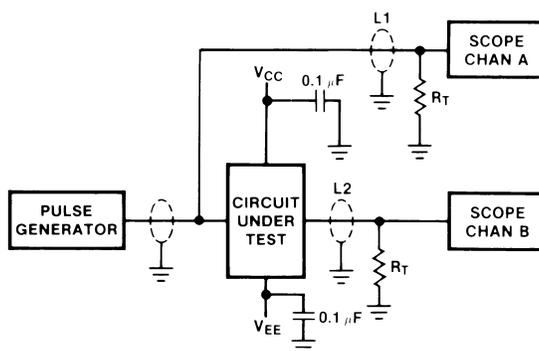
AC Electrical Characteristics

 $V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = V_{CCA} = GND$

Symbol	Parameter	$T_C = -55^\circ\text{C}$		$T_C = +25^\circ\text{C}$		$T_C = +125^\circ\text{C}$		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max			
t_{PLH} t_{PHL}	Propagation Delay Data to Output	0.25	1.70	0.30	1.50	0.30	1.80	ns	⁽¹⁾ Figure 3	
⁽²⁾⁽³⁾⁽⁴⁾⁽⁵⁾ t_{TLH} t_{THL}	Transition Time 20% to 80%, 80% to 20%	0.30	1.20	0.30	1.20	0.30	1.20	ns		

- (1) AC Test Circuit
- (2) F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals -55°C), then testing immediately after power-up. This provides “cold start” specs which can be considered a worst case condition at cold temperatures.
- (3) Screen tested 100% on each device at $+25^\circ\text{C}$ temperature only, Subgroup A9.
- (4) Sample tested (Method 5005, Table I) on each manufactured lot at $+25^\circ\text{C}$, Subgroup A9, and at $+125^\circ\text{C}$ and -55°C temperatures, Subgroups A10 and A11.
- (5) The propagation delay specified is for single output switching. Delays may vary up to 100 ps with multiple outputs switching.
- (6) Not tested at $+25^\circ\text{C}$, $+125^\circ\text{C}$, and -55°C temperature (design characterization data).

Test Circuitry



Notes:

V_{CC}, V_{CCA} = +2V, V_{EE} = -2.5V

L1 and L2 = equal length 50Ω impedance lines

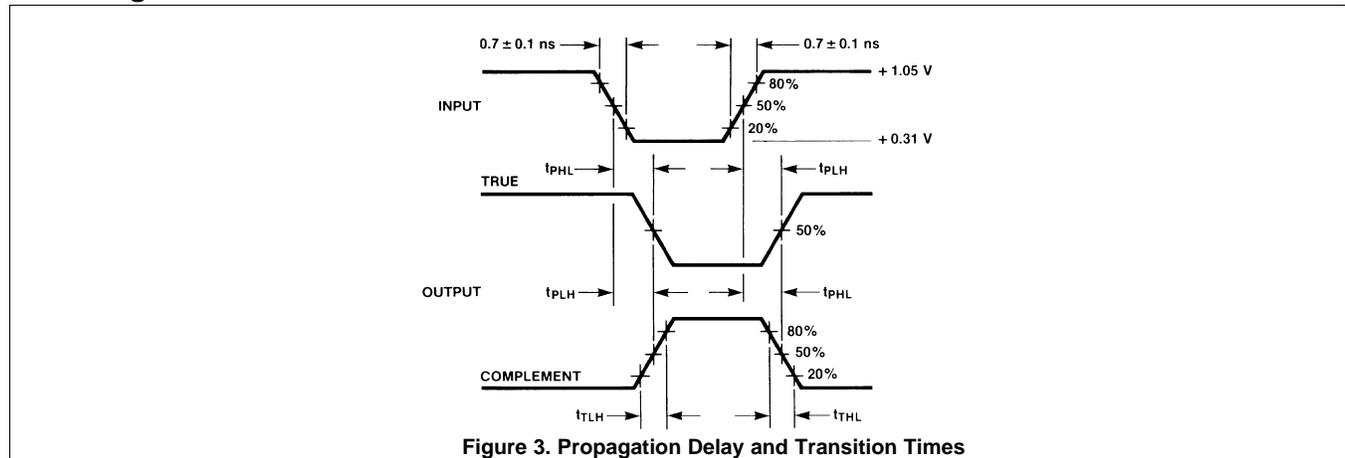
R_T = 50Ω terminator internal to scope

Decoupling 0.1 μF from GND to V_{CC} and V_{EE}

All unused outputs are loaded with 50Ω to GND

C_L = Fixture and stray capacitance ≤ 3 pF

Switching Waveforms



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